IEC 61850-Based Centralized Intelligent Station-Level Protection (CISP) for Power Systems with Multi-Technology DERs

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- Methodology
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Background

Grid Integration of renewables and DERs:

- Types of DER
- Locations
- Operating modes
- Types of technology

Trend towards IIDERs

- PV
- Wind
- Energy storage





Background

Impact of DERs on Distributions Systems

- Bidirectional distribution system
- Intermittent power flow
- Variable fault current
- Operating modes
 - Grid-connected mode
 - Islanded mode
- Dynamic electricity markets

Impact of DERs on Protection

- Loss of protection coordination
- Sympathetic tripping
- Protection blinding
- Reclosing problem
- Dynamic protection zones



Background





IEC 61850-Based Technology

- Object-oriented modelling approach
- IEC 61850 Services



Logical levels and interfaces in IEC 61850 Standard

HV Equipment

IEC 61850, "Communication networks and systems in substations," International Electrotechnical Commission (IEC), 2003.

standard



SUBSTATION

В

BAY/UNIT

LEVEL

PROT.

CONTR.



Centralized protection architecture for networked microgrids





Proposed architecture for centralized protection of networked microgrids



Centralized Intelligent Station-Level Protection (CISP):

- Sensor module
 - CTs/VTs or NCITs
 - IEC 61850/61869-9 Merging Units (MUs)
- Zone selection module
 - Graph theory-based topology processor
 - Zone selection
- Protection module
 - Supervised Current Differential (SCD)
 - Incremental Transient Energy (ITE) Directional Algorithm
 - Directional-Rate of Change of Current (D-ROCOC)
- Actuation module
 - Fault Interrupting Devices (FIDs)
 - Breaker failure algorithm



Methodology: Zone Selection

- Graph G{V, E} using an a n × n adjacency matrix A.
 Vertices V = {v₀, v₁, ..., v_n } is a non-empty finite set of elements
- Edges E = {(v₀, v₁), ..., (v_i, v_j), ..., (v_m, v_n) } is a finite set of unordered elements. An edge e_{ij} is a pair of vertices (v_i, v_j), and v_i and v_j are referred to as adjacent or neighboring vertices.
- Table I: Graph-zone descriptions used.

Graph Component	Description		
Network graph	Networked microgrids (MGs)		
Subnetworks	Individual MGs		
Vertices	Busbars, nodes		
Edges	Circuit Breakers (CBs), switches,		
	disconnectors, CTs, CB-CT branches, fuses,		
	power transformers		
Subgraphs (Z _B)	Vertices with degree $d(v) > d_{thr}$.		
Shortest path (Z _F)	Path between subgraphs		
MG Diameter (Z _{EH})	Path between end vertices in the MGs and		
	hubs		



Zone selection flowchart



Methodology: Zone Selection





Methodology: Protection Algorithms

ITE-Based Directional Algorithm

The voltage
$$(v^{fault})$$
 and current (i^{fault}) during the fault are:
 $v^{fault}(t) = v^{pre}(t) + \Delta v(t)$ (1)
 $i^{fault}(t) = i^{pre}(t) + \Delta i(t)$ (2)

where v^{pre} and i^{pre} are the prefault voltage and current quantities, Δv is the superimposed (incremental) voltage, and Δi is the superimposed current.

The differential (interphase) incremental transient energy is:

$$e_{inc,AB}(t) = \int_0^T \Delta v_{AB}(t) \cdot \Delta i_{AB} dt$$
(3)
$$e_{inc,CA}(t) = \int_0^T \Delta v_{CA}(t) \cdot \Delta i_{CA} dt$$
(4)

where $e_{inc,AB}$, Δv_{AB} , and Δi_{AB} are the differential incremental energy transient, incremental voltage, incremental currents between phases A and B.

$$\Delta i_{AB} = \left(i_A^{fault} - i_B^{fault}\right) - \left(i_A^{pre} - i_B^{pre}\right)$$
(5)
$$\Delta v_{AB} = \left(v_A^{fault} - v_B^{fault}\right) - \left(v_A^{pre} - v_B^{pre}\right)$$
(6)

Similar derivation applies for the differential quantities for phase CA.



Methodology: Protection Algorithms

(8)

Adaptive Supervised Current Differential (SCD)

$I_{DIF,Ph} = \left \sum_{k=1}^{N} i_{k,Ph}(t) \right $	
$I_{RST,Ph} = k_{res} \times max \big i_{k,Ph}(t) \big $	

where i_k is the current at the kth terminal, N is the number of terminals connected to the protected zone, Ph denotes phases A, B, and C, and k_{res} is the restraining current multiplying factor (typically 0.5 or unity).

The dual slope percentage differential characteristic is: $I_{DIF Ph} \geq$ $\begin{cases} I_{Dmin,Ph} + K_1 I_{RST,Ph} & when I_{RST} < I_{R2,Ph} \\ I_{Dmin,Ph} + (K_1 - K_2) I_{R2,Ph} + K_2 I_{RST,Ph} & when I_{RST} \ge I_{R2,Ph} \end{cases}$ (9)

Directional-Rate of Change of Current

The ROCOC at the *j*th path is given as: $\left|\frac{di^j}{dt}\right| = \frac{i_n^j - i_{n-1}^j}{\Delta T_c}$ (10)





Hardware Implementation



Hardware implementation architecture



Hardware Implementation



- RTDS Rack-to-RTDS Rack: GTFPGA-SV publishing
 - Multiple streams of sampled values of currents and voltages
 - Sampling rate of 96 s/c
- RTDS Rack-to-RTDS Rack: GTNET-SV subscription
- RTDS Rack-to-RTDS Rack: GTNET-GOOSE subscription
- RTDS-to-MATLAB: GTNET SKT Protocol



Results: Zone Selection



 $\overline{\mathbf{0}}$

n

0 0

Λ





Adjacency matrix and graph for IEEE 13-node feeder (a) steady-state,

(b) Node-671-684 CBs open, (c) open CBs at Line 645-646, line 633-, PV, and BESS



Results: Zone Selection

TABLE III: Protection zones for some scenarios

Case study	Scenario	Number of Prot.	Protection zones
		zones	
Case study-1	Steady-state (All CBs closed)	6	Z _B : {632,671,645,633}, {671,680,684,692}, {684,611,671,652} Z _F : {632-671}, {684-671} Z _{FH} : {646-632}
Case study-2	Node-671 CB open	5	$Z_{B}^{-1}:\{632,671,645,633\},\{671,680,684,692\},\{684,611,671,652\}$ $Z_{F}:\{684-671\}$ $Z_{EH}:\{646-632\}$
Case study-3	Node-633, 645, 646, PV, BESS CBs open	4	Z_{B}^{-1} :{632,671,645,633},{671, 680,684,692}, {684,611,671,652} Z_{F}^{-1} : {684-671}



Results: Faults Currents from Sources



Fault current contributions (a) Grid-connected mode, (b) Islanded mode

$$I_{fault,m} = \left(Op_{bit,G} \times I_{k,G} \times I_{Grid}\right) + \sum_{i=1}^{j} \left(Op_{bit,i} \times I_{k,i} \times I_{DER,i}\right)$$
(11)

where $Op_{bit,G}$ — operating mode of the grid $Op_{bit,i}$ — operational DER(s) in the interconnected microgrids $I_{k,G}$ and $I_{k,i}$ are the estimated average fault current multiplying factors from the grid and the *i*th DER in the microgrid, respectively.



Results:

5





Results: Fault at Node-632 (F1)



Fault currents at F1 (Node-632) for (a) Grid-connected mode, (b) Islanded mode



Results: Fault at Node-632 (F1)



Results: Fault at Node-632 (F1)



Directional ITE algorithm at Node-632 terminals for (a) internal fault at F1 and (b) external fault.



Results: Fault at Node-692-675 (F4)





Communication Network Emulator





Communication Network Emulation





Communication Network Emulator

- ARP spoofing of GTNET MAC/IP addresses
 Communication QoS for SKT communication
 Communication QoS for MMS
- Communication QoS for IEC 61850 SVs and GOOSE messages



Х

Conclusion

Deliverables

- IEC 61850-based lab-scale proof-of-concept microgrid protection testbed
- Development of a centralized protection approach
- Formulation of protection algorithms suitable for microgrids

Future work

- Impact of communication issues on centralized protection
- Cyber security of electric power infrastructure
- Deployment of the protection algorithms on an embedded system



Questions?

Comments

